



Full Length Article

Structural, optical and electrochromic properties of WAW films for profound electrochromic applications deposited by DC & RF magnetron sputtering

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ARTICLE INFO

Keywords:

Electrochromism

WO₃/Ag/WO₃ (WAW)

Tungsten oxide (WO₃)

Sputtering and coloration efficiency

ABSTRACT

One of the most frequently used transition conducting oxides (TCO) is indium tin oxide. Indium is very expensive because of the lack of availability. So Most of the researchers focused on cost-effective materials and they have developed Dielectric/Metal/Dielectric (DMD) structures for ITO-free applications. Examples of dielectric materials are AZO, MoO₃, TiO₂, and WO₃. The dielectric material is sandwiched between metals such as Au, Ag, Pt, Cu, and Al. The efficacy of these DMD structures is purely based on the thickness of the dielectric and metal layers. Once the metal layer thickness is more than 15 nm, the transmittance is much less due to the thickness of the material and it will work as a reflector. Moreover, as WO₃ is the most widely and frequently used material we focus on the fabrication of WO₃/Ag/WO₃ (WAW) for replacing TCO in the electrochromic device and making it indium-free. WAW structures are widely used in smart windows, gas sensors, solar cells, photodetectors, etc. For electrochromic applications, these WAW structures showed good transmittance, fast switching speed, best coloration efficiency, and best optical modulation in comparison to WO₃/ITO structure and are also cost-effective.

1. Introduction

Indium Tin Oxide (ITO) is one of the most frequently used TCO materials. High electrical conductivity and transmittance are the major requirements for an ideal transparent conducting electrode (TCE) application such as touch panels, organic light-emitting diodes, gas sensors, flat panel displays, solar cells, plasma displays, etc. [1]. An ideal TCO should have low resistivity and optical transmittance of 80% or more in the range of 400 to 800 nm [2]. Different metal oxide semiconductors like SnO₂, TiO₂, ZnO, and In₂O₃ have been used to fabricate transparent conducting oxide (TCO) thin films [3]. The most common

TCO are semiconductor metal oxides with large bandgaps such as zinc oxide, tin oxide, indium oxide, and cadmium doped with group III (Al) [4–8], B [9], Ga [10] or group VII (F [11], Cl [12]). These elements have low resistivity and maintain high transmittance in the visible range. Amidst all, Indium tin oxide (ITO) is the most frequently used Transparent conducting oxide (TCO) material. However, it is rarely available and hence expensive. To overcome this problem researchers are dedicated to finding new transparent conductive electrodes such as nanowires, nanotubes, dielectric-metal-dielectric (D/M/D), graphene, and related structures. Amidst sandwiching a thin metal layer between two dielectric layers D/M/D has been recently introduced as an ideal

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<https://doi.org/10.1016/j.chphi.2024.100566>

Received 31 December 2023; Received in revised form 1 March 2024; Accepted 10 March 2024

Available online 11 March 2024

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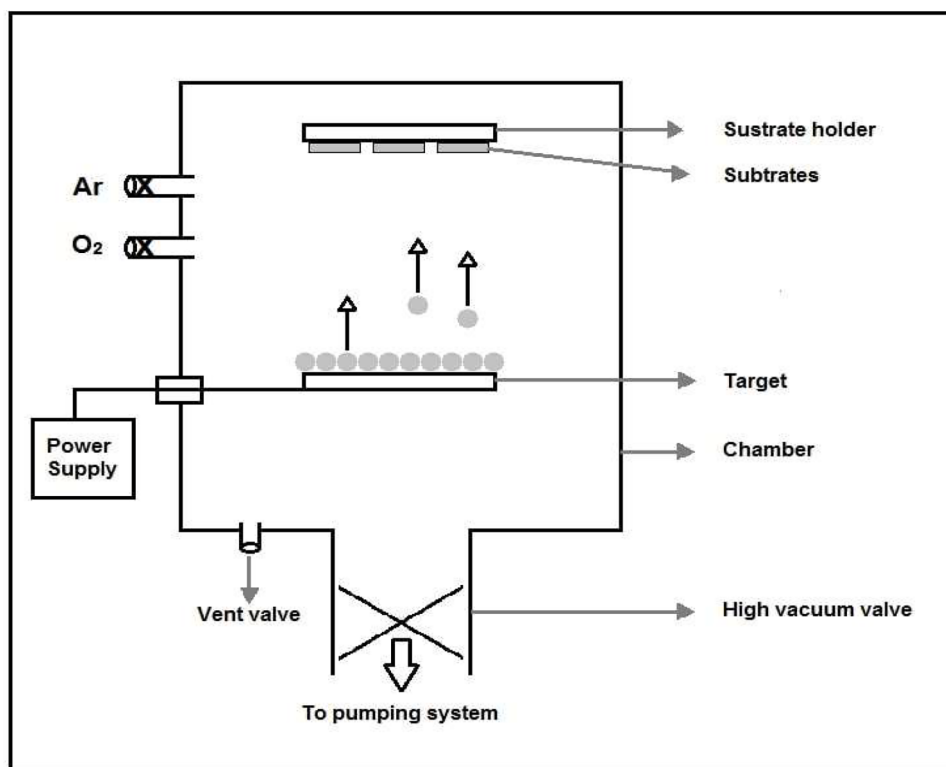


Fig. 1. Schematic representation of Sputtering System.

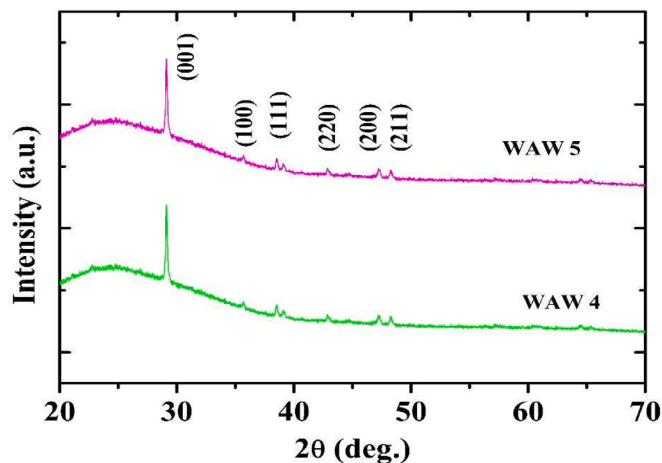


Fig. 2. XRD plots of WAW 4 and WAW 5 structure.

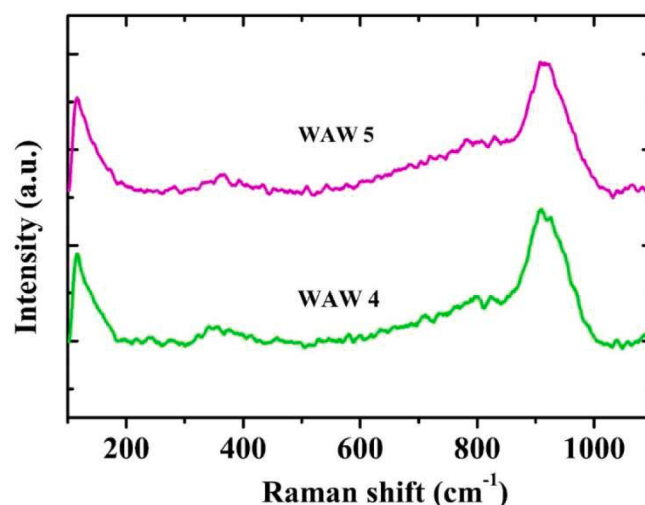


Fig. 3. Raman analysis of WAW 4 and WAW 5 structure.

alternative approach to obtain the combined benefits of high transmission as well as excellent conductivity [13,14]. The efficacy of multilayer transparent DMD structures is dependent on the optimization of the thickness of the dielectric and metal layers [15].

Xuanjie Liu et al. designed flat panel displays with a multilayer structure of ZnS/Ag/ZnS. The electrical and optical performance of the device depends on the thickness of the silver layer approximately 12 nm [16]. For the electrochromic applications, various structures of DMD are there, such as MoO₃/Ag/MoO₃ [17], TiO₂/Ag/TiO₂ [18], and WO₃/Ag/WO₃ [19]. Among these DMD structures, the WO₃/Ag/WO₃ structure is the best for electrochromic applications.

For the electrochromic applications, we have several electrochromic materials. These materials are classified into organic and inorganic materials. Inorganic materials such as TiO₂ [20], NiO [21], V₂O₅ [22], WO₃ [23–25] and organic materials are viologens [26], poly (3,4

ethylene dioxythiophene) (PEDOT) [27], polyaniline (PANI) [28]. Among all materials, inorganic material tungsten oxide (WO₃) has a quick response, good optical transmittance, long life, coloration efficiency, a wide bandgap, and good semiconductor properties. It is best for electrochromic applications and gas sensors [29]. WO₃ films also possess photochromic [30], gasochromic [31], and good hydrophilic [32] properties. The first electrochromic study on WO₃ was reported in 1969 [33]. In the preparation of WO₃ thin films, several deposition methods are there, they are electron beam evaporation [34–36], thermal evaporation [37,38], DC and RF magnetron sputtering [39–58], hydrothermal methods [59–66], plasma spraying method [67], and sol-gel method [68]. With above stated physical vapor deposition techniques we first try to optimize the thickness of WO₃ to realize DMD structure by

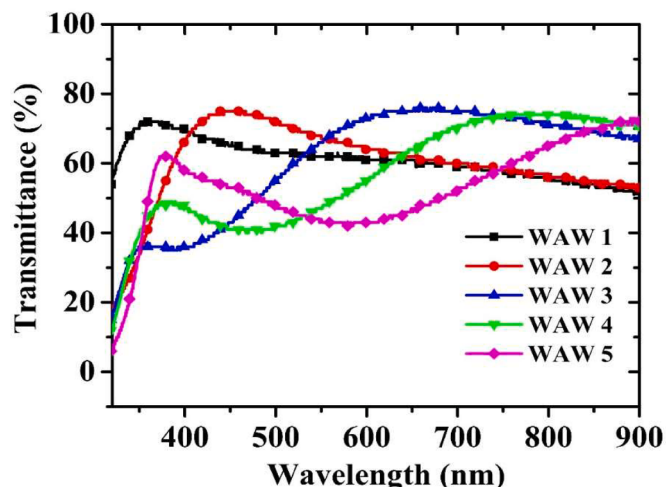


Fig. 4. The optical transmittance of WAW structure with different thicknesses.

incorporating WAW configuration.

WAW is not only for electrochromic applications but also for solar cells [69] and light-emitting diodes [70]. In transparent conducting DMD structures, the major role is played by the thickness of the metal layer. The metal layer could be of Al, Cu, Au, Pt, and Ag. In higher thickness, these metals work as reflectors. The preferred thickness of the metal

layer is around 10 to 20 nm. In this range, the metal layer works as transparent and conducting material. Amidst all metals, Ag exhibits the best conducting and photodetector characteristics and is lower in work function compared to other metals [2].

The aim of this study is to develop the indium-free transparent electrode $\text{WO}_3/\text{Ag}/\text{WO}_3$ (WAW) thin film for electrochromic applications because of the lack of availability of the Indium tin oxide (ITO) and its cost. In this structure, we have varied the thickness of the bottom and top layers of WO_3 thin film thickness and we have kept the metal layers' thickness constant as Ag (12 nm), and W (3 nm). The WO_3 films and Ag films were deposited on the corning glass by using DC and RF magnetron sputtering. The structural, optical, and Electrochromic properties of WO_3 thin films were discussed.

2. Materials and experimental method

2.1. Materials used

The specifications of the corning glass are pre-cleaned $28,947\text{--}75 \times 25$ mm, thickness 0.96 to 1.06 mm from Corning Incorporated, USA. The DI water, H_2SO_4 , soap solution, and beakers, were purchased from the Vasa scientific Bangalore, India. $\text{Hg}_2/\text{HgCl}_2$ and platinum wire were purchased from Sinsil International Pvt Ltd, Bangalore, India. Argon gas (99.999%) and Oxygen gas (99.999%) gas cylinders were purchased from the Bhuruka gas agencies, in Bangalore, India. A pure 3-inch diameter tungsten (W) and Silver (Ag) metallic disk were purchased from the scientific and analytical instruments, in New Delhi, India.

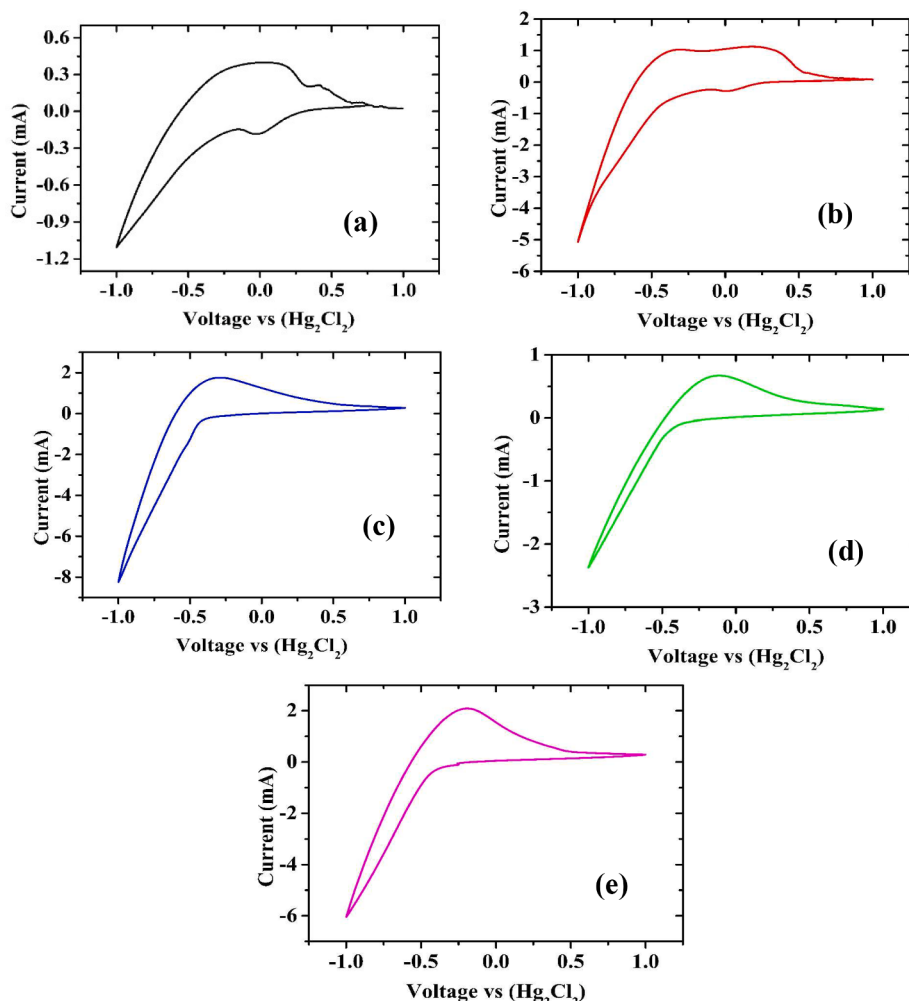


Fig. 5. CV plots of (a) WAW 1, (b) WAW 2, (c) WAW 3 (d) WAW 4 and (e) WAW 5 structure.

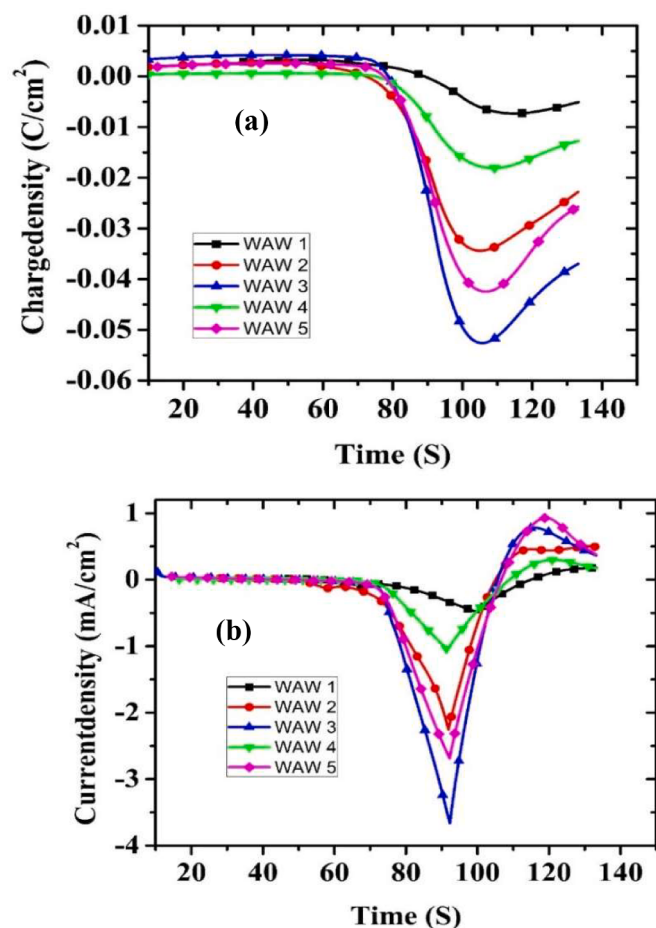


Fig. 6. (a) Charge density, and (b) Current density vs time plots of WAW structure.

2.2. Experimental method

Indium-free transparent electrochromic material was deposited as a $\text{WO}_3/\text{Ag}/\text{WO}_3$ thin film structure at room temperature using RF and DC magnetron sputtering. These thin films are deposited on corning glass substrates. The sputtering chamber was evacuated 1×10^{-6} mbar by using the mechanical pump as a Rotary pump (up to 1×10^{-3} mbar) and the backing pump as a turbo molecular pump (up to 1×10^{-6} mbar). Inside the chamber pressure was measured using penning and pirani gauges. Before loading the substrate inside the chamber substrates were cleaned ultrasonically following soap solution, DI water and dried with nitrogen gas. A pure 3-inch dia tungsten (W) and Silver (Ag) metallic disk were used. In this work, we have used pure Argon gas (99.999%) as a sputtering gas with a flow rate of 25 SCCM and oxygen gas (99.999%) as a reactive gas with a partial pressure of 8×10^{-4} mbar. For the deposition of tungsten oxide (WO_3) and Silver (Ag) thin films, the distance between the substrate and the target was maintained at 9 cm and 7 cm respectively. The WO_3 and Ag thin films were coated using DC and RF magnetron sputtering respectively. For every deposition before W and Ag metal targets were presputtered in the Argon environment for 10 min and 2 min to remove the adsorbed contaminations from the targets. The Schematic representation of the sputtering system is shown in Fig. 1. The films with pattern of WAW 1 ($\text{WO}_3/\text{Ag}/\text{W}/\text{WO}_3$, 25/10/3/25 nm), WAW 2 ($\text{WO}_3/\text{Ag}/\text{W}/\text{WO}_3$, 50/10/3/50 nm), WAW 3 ($\text{WO}_3/\text{Ag}/\text{W}/\text{WO}_3$, 75/10/3/75 nm), WAW 4 ($\text{WO}_3/\text{Ag}/\text{W}/\text{WO}_3$, 100/10/3/100 nm), and WAW 5 ($\text{WO}_3/\text{Ag}/\text{W}/\text{WO}_3$, 125/10/3/125 nm).

3. Materials and characterization

The deposited WAW films have been carefully characterized. Raman and XRD were used to examine the structural characteristics (Rigaku-MiniFlex). A UV-vis spectrometer (SPECORD S600, Analytikjena) was used to record the optical transmittance spectra of WAW thin films in the 200–1100 nm range. Using an electrochemical analyzer, the electrochromic behavior of WAW thin films was investigated. This electrochemical device includes a three-electrode configuration (SP-300, Biologic) with platinum, $\text{Hg}_2/\text{HgCl}_2$, and WAW thin film electrodes are counter electrode, reference electrode and working electrode respectively. The CV tests were conducted in a solution with a concentration of 0.5 M of H_2SO_4 , using potential ranges from -1 V to 1 V, and a scan rate of 30 mVs^{-1} was used.

4. Results and discussions

4.1. XRD analysis

Fig. 2. shows the XRD results of WAW 4 and WAW 5 thin films deposited by using DC and RF magnetron sputtering at RT. The figure shows the diffraction peaks of crystalline Ag metal. The diffraction angle 2θ values are 29.08° of (001), 35.77° of (100), 39.05° of (111), 42.89° of (220), 47.17° of (200), and 48.27° of (211). The crystallite size (D) of the WO_3 films was calculated by using Debye-Scherrer's relation shown in the equation.

$$D = \frac{0.96 \lambda}{\beta \cos \theta} \quad (1)$$

Where θ , β , and λ , are the diffraction angle, FWHM, and wavelength. The calculated Full width at half maximum (FWHM) and crystallite sizes of WAW 4 and WAW 5 are 27.72° and 0.6 nm respectively [71–75]. It's worth noting that none of the patterns show any WO_3 peaks, indicating that the WO_3 layer was amorphous under the deposition conditions, which is good for EC performance [33]. The possible reason is that during the process of depositing the coating layer, the oxygen of the reaction gas flowing into the chamber was dissociated into oxygen ions by the plasma, and the silver was easily combined with oxygen, yet the active oxygen ions were made before the deposition of the tungsten oxide.

4.2. Raman analysis

Raman spectroscopy was used to characterize the crystalline nature and chemical bonding of the WAW films deposited by using DC and RF magnetron sputtering shown in Fig. 3. Raman spectra of WO_3 thin films show two broad bands, one is lower frequency and another higher frequency ie $200\text{--}400 \text{ cm}^{-1}$ and $700\text{--}1000 \text{ cm}^{-1}$. In the low-frequency region, the band observed at around 241 cm^{-1} is attributed to δ (O-W-O). At higher frequencies, broad Raman peaks were observed at around 943 cm^{-1} and 771 cm^{-1} attributed to stretching mode vibration modes of the bridging oxygen $\text{W}=\text{O}$ and O-W-O , respectively.

4.3. Optical properties

The thickness of each layer has a significant impact on the optical and electrical properties of stacked WAW films. The films have a thin but continuous center metal layer that ensures low absorption and sheet resistance. High transmittance and great EC performance would be possible if the inner and outer dielectric layers were of sufficient thickness. The optical transmittance of WAW thin film structure with different thicknesses is shown in Fig. 4. The transmittance varied from 73%, 61%, 64%, and 43% at a wavelength of 600 nm. Fig. 2 shows the WAW 3 structure shows the higher the transmittance and the lower at WAW 5. We have deposited the WO_3 thin film layer on the glass substrate as a bottom layer, on top of the silver layer was coated. To

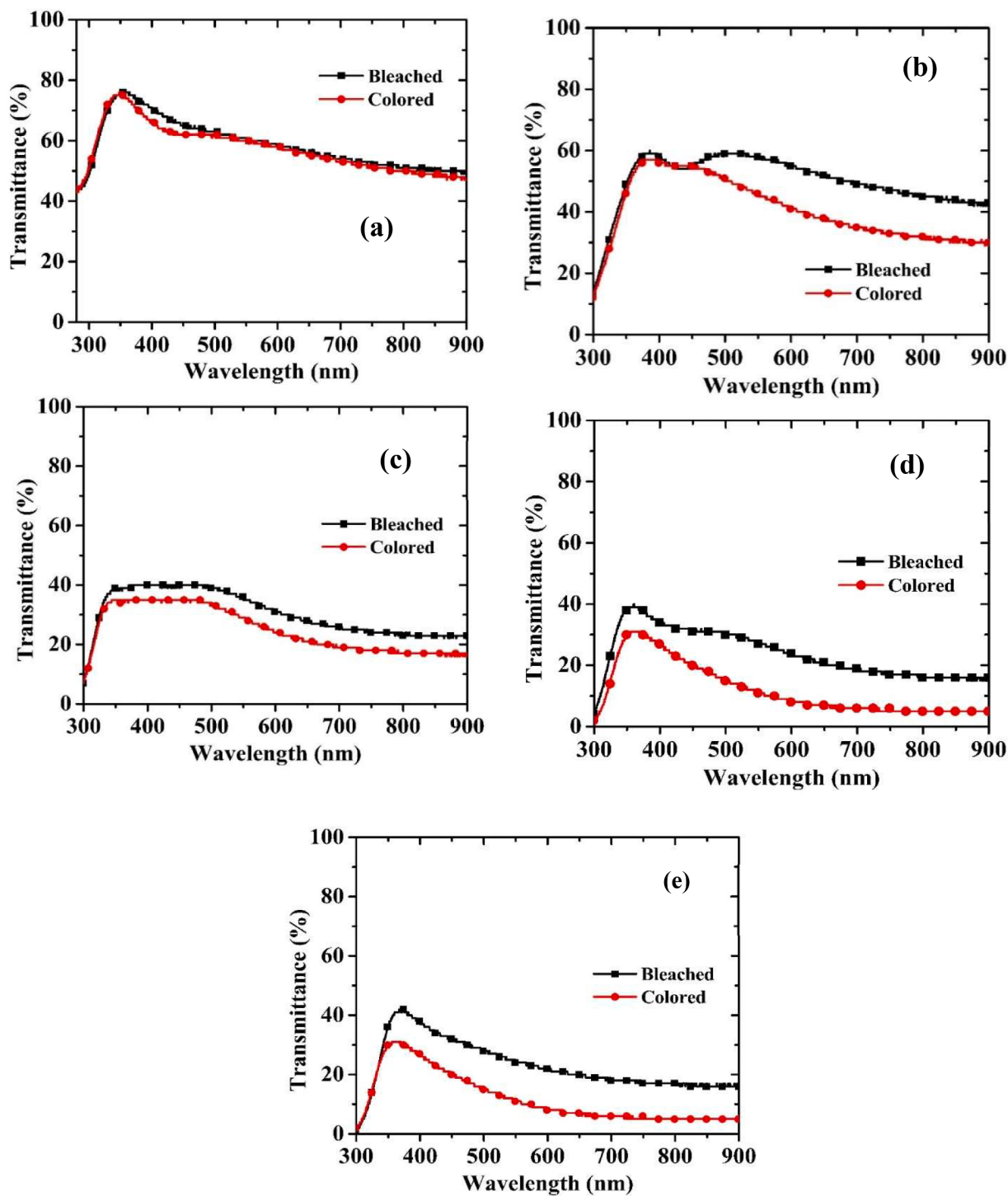


Fig. 7. bleached and colored states of (a) WAW 1, (b) WAW 2, (c) WAW 3 (d) WAW 4 and (e) WAW 5 structure.

avoid the silver oxidation, we have introduced a sacrificial layer of the tungsten metal layer with a fixed thickness, then we have coated the top layer of WO_3 thin film. We have observed that without a sacrificial layer of tungsten metal, the entire device is insulating and it is not working due to the oxidation of silver and the conductivity of the silver decrease. we can see that as we increase on top and bottom layer thickness the transmittance was decreased with a fixed thickness of Ag and W. The calculated bandgap values are 3.20 eV, 2.83 eV, 3.32 eV, 3.39 eV, and 3.25 eV for WAW-1, WAW-2, WAW-3, WAW-4, and WAW-5 respectively. The calculated sheet resistance is 16.75, 16.28, 15.45, 13.25 and 14.4 $\Omega/\square$ for WAW-1, WAW-2, WAW-3, WAW-4, and WAW-5

respectively [76,77].

4.4. Electrochemical studies

Fig. 5 shows the Cyclic Voltammetry (CV) plots of WAW thin films deposited by using DC and RF magnetron sputtering on corning glass substrate at room temperature. The electrochromic studies were done by using a programmable three-electrode electrochemical setup. The electrodes are WE as WAW, RE as $\text{Hg}/\text{Hg}_2\text{Cl}_2$, and AE as platinum wire. The CV analysis was done with the electrolyte of 0.5 M of H_2SO_4 and with a scan rate of 30 mVs^{-1} in the potential range of $\pm 1 \text{ V}$. From CV plots the

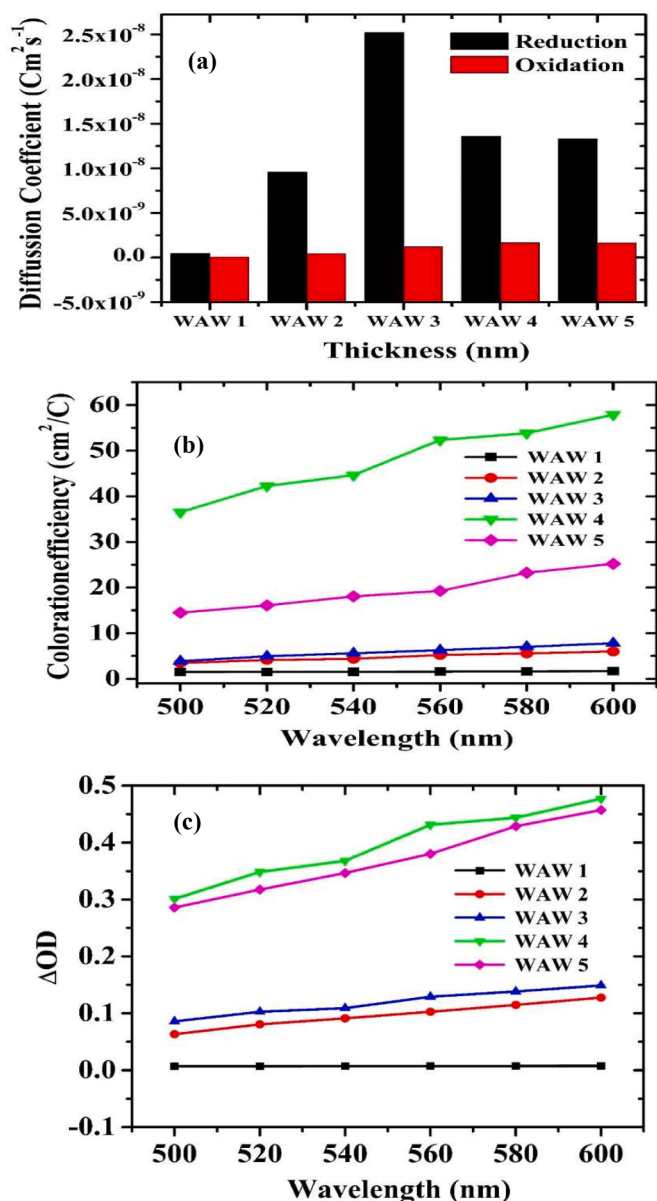


Fig. 8. (a) Diffusion Coefficient, (b) Coloration efficiency, and (c) optical density of WAW structure.

reduction current was shown as 1.11 mA, 5.09 mA, 8.27 mA, 6.10 mA, and 6.01 mA for WAW-1 to WAW-5 respectively. A higher reduction current was shown in the sample WAW-3.

Fig. 6. (a & b) show the charge and current density vs time plots of the WAW structures and observed high values for both the charge and current density for the WAW-3 structure. The transmittance for the bleached and colored state of the WAW structure is shown in Fig. 7. The observed bleached transmittance values are 58%, 55%, 31%, 24%, 22% and colored transmittance values are 56%, 41%, 22%, 2%, and 7% for WAW-1 to WAW-5 respectively. From these transmittance results, the optical modulation was shown higher for WAW-4. The diffusion coefficient plots of the WAW structure are shown in Fig. 7(a). It is varied from 4.54×10^{-10} , 9.54×10^{-9} , 2.52×10^{-8} , 1.35×10^{-8} and $1.33 \times 10^{-8} \text{ cm}^2 \text{ s}^{-1}$ for WAW-1 to WAW-5 respectively, and the higher diffusion coefficient was observed in WAW-3 structure. The coloration efficiency (CE) of the WAW structure is shown in Fig. 7(b). It varied from 1.6, 5.88, 7.8, 57.87, and 25.19 $\text{cm}^2 \text{ C}^{-1}$ for WAW-1 to WAW-5 respectively at the wavelength of 600 nm and the higher CE was observed in the WAW-4 structure [78,79], (Fig. 8).

5. Conclusions

Indium-free transparent WAW thin films have been successfully deposited by using the DC and RF magnetron sputtering. The structural, optical, and electrochromic properties of WAW thin films were systematically analyzed. From the optical transmittance data, transmittance varied from 73%, 61%, 64%, 55%, and 43% with respect to the thickness of the WAW thin film was observed. From electrochemical analysis higher current and diffusion coefficients were observed for WAW 3 thin film. The coloration efficiency was observed at 57.87 $\text{cm}^2 \text{ C}^{-1}$.

Funding

The authors thank the Researchers Supporting Project number (RSP2024R169), King Saud University, Riyadh, Saudi Arabia for the financial support.

Ethical approval

Not Applicable

CRediT authorship contribution statement

K Naveen Kumar: Methodology, Investigation, Funding acquisition. Habibuddin Shaik: Validation, Methodology, Investigation, Funding acquisition. Sheik Abdul Sattar: Validation, Methodology, Investigation, Funding acquisition. Ashok Reddy G V: . Ramanadha Mangiri: Validation, Investigation. R Imran Jafri: Validation, Methodology, Investigation, Funding acquisition. R. Premkumar: Validation, Investigation. R. Govindharaju: Investigation, Validation, Writing – review & editing. B. Mary Juliet: Investigation, Validation, Writing – review & editing. Sabah Ansar: Writing – review & editing.

Declaration of competing interest

The authors declare that they have no known competing financial interests or personal relationships that could have appeared to influence the work reported in this paper.

Data availability

The data that has been used is confidential.

Acknowledgement

The author acknowledges AICTE for financial support, the project Ref: 8–39/RIFD/RPS/POLICY-1/2016–2017, and the authors thank the Researchers Supporting Project number (RSP2024R169), King Saud University, Riyadh, Saudi Arabia for the financial support.

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